Dr Christopher Frost

Publications, Reports and Media Output

Papers Relating to Neutron Irradiation since 2007

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1. *The MIGDAL experiment: Measuring a rare atomic process to aid the search for dark matter*
   Araújo, HM; Balashov, SN; Borg, JE; Brunbauer, FM; Cazzaniga, C; Frost, CD; Garcia, F; Kaboth, AC; Kastriotou, M; Katsioulas, I et al; Astroparticle Physics, 151, 102853, 2023

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   Coronetti, Andrea; Alía, Rubén García; Lucsanyi, David; Letiche, Manon; Kastriotou, Maria; Cazzaniga, Carlo; Frost, Christopher D; Saigné, Frédéric; IEEE TRANSACTIONS ON NUCLEAR SCIENCE, VOL. 70, NO. 8, AUGUST 2023

3. *Fast neutron response characterization of an EJ-276 plastic scintillator for use as a neutron monitor*
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5. *Impact of Temperature on Neutron Irradiation Failure-in-Time of Silicon and Silicon Carbide Power MOSFETs*
   Principato, Fabio; Cazzaniga, Carlo; Kastriotou, Maria; Frost, Christopher; Abbene, Leonardo; Pintacuda, Francesco; Radiation, 3, 2, 110-122, 2023

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117. *Talk: STFC Talking Science Lecture: How alien invaders can change governments: The dangers of fast neutrons to advanced electronics (24 May 2012)*

118. *Interview: Naked Scientist Podcast (25 November 2012)* Time – 36:19 Onwards
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121. *Talk: AAAS 2017 Meeting: Cloudy with a Chance of Solar Flares: Quantifying the Risk of Space Weather*
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